Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/765,670	MURAYAMA ET AL.		
Examiner	Art Unit		
Andrew Lee	2616		

SEARCHED					
Class	Subclass	Date	Examiner		
370	252, 537	4/11/2006	AL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

ES STRATEGY)
DATE	EXMR
4/11/2006	AL
	5
	DATE